

Search Notes

Application/Control No.

10/604,250

Examiner

Long K. Tran

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2818

SEARCHED

Class	Subclass	Date	Examiner
257	59,72	2/8/2005	LKT
349	149,150	2/8/2005	LKT
349	151,152	2/8/2005	LKT
349	129	2/8/2005	LKT
324	770	2/8/2005	LKT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	59,72	2/8/2005	LKT
349	149,150	2/8/2005	LKT
349	151,152	2/8/2005	LKT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST searched	2/8/2005	LKT
EAST searched	2/9/2005	LKT